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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Masaaki KURIHARA et al.

Serial No.: 10/614,345

Filed: July 8, 2003

For: PHASE MASK FOR FORMING DIFFRACTION GRATING,

METHOD OF FABRICATING PHASE MASK AND METHOD

FOR FORMING DIFFRACTION GRATING

# REQUEST FOR CORRECTED FILING RECEIPT

Commissioner for Patents
Office of Initial Patent Examination
Filing Receipt Corrections - Fax No.: 703-746-9195
P.O. Box 1450
Alexandria, Virginia 22313-1450

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Sir:

A corrected filing receipt is hereby requested in view of the error which appears in the original. For the convenience of the Patent and Trademark Office, attached is a photocopy of the original receipt on which the errors have been noted in red.

Respectfully submitted,

Roger W. Parkhurst

Robert N. Wieland

Registration No. 25,177

Registration No. 40,225

PARKHURST & WENDEL, L.L.P.

Date: March 2, 2004

Attorney Docket No.: <u>DAIN:740</u>
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Alexandria, Virginia 22314-2805
Telephone: (703) 739-0220

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MAR-02-2004

## United States Patent and Trademark Office

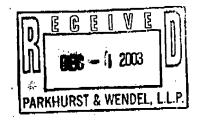
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**CONFIRMATION NO. 7853** 

6160 PARKHURST & WENDEL, L.L.P. 1421 PRINCE STREET **SUITE 210 ALEXANDRIA, VA 22314-2805** 



**FILING RECEIPT** OC000000011359800

Date Mailed: 11/26/2003

Receipt is acknowledged of this regular Patent Application. It will be considered in its order and you will be notified as to the results of the examination. Be sure to provide the U.S. APPLICATION NUMBER, FILING DATE, NAME OF APPLICANT, and TITLE OF INVENTION when inquiring about this application. Fees transmitted by check or draft are subject to collection. Please verify the accuracy of the data presented on this receipt. If an error is noted on this Filing Receipt, please write to the Office of Initial Patent Examination's Filing Receipt Corrections, facsimile number 703-746-9195. Please provide a copy of this Filing Receipt with the changes noted thereon. If you received a "Notice to File Missing Parts" for this application, please submit any corrections to this Filing Receipt with your reply to the Notice. When the USPTO processes the reply to the Notice, the USPTO will generate another Filing Receipt incorporating the requested corrections (if appropriate).

## Applicant(s)

Masaaki Kurihara, Shinjuku-Ku, JAPAN: Nobuhito Toyama, Shinjuku-Ku, JAPAN:

## **Assignment For Published Patent Application**

Dal Nippon Printing Co., Ltd., Shinjuku-Ku, JAPAN;

Domestic Priority data as claimed by applicant

#### Foreign Applications

JAPAN 2002-200558 07/09/2002

If Required, Foreign Filing License Granted: 11/25/2003

Projected Publication Date: To Be Determined - pending completion of Missing Parts

Non-Publication Request: No

Early Publication Request: No

Title

Phase mask for forming diffraction grating, method of fabricating phase mask, and method of